

Notice of References Cited	Application/Control No. 10/689,488	Applicant(s)/Patent Under Reexamination KHALID ET AL.	
	Examiner JOHN J LEE	Art Unit 2684	Page 1 of 1

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	B	US-2003/0114198	06-2003	Han, Shin	455/566
	C	US-2004/0121825	06-2004	Ma et al.	455/575.4
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